<IGBT Modules>

CM150MXUD-24T/CM150MXUDP-24T

HIGH POWER SWITCHING USE
INSULATED TYPE

MXUD		Collector current I_C ..... **150** A Collector-emitter voltage V_{CES} ..... **1200** V Maximum junction temperature T_{vjmax} ..... **175** °C ●Flat base type ●Copper base plate (Nickel-plating) ●RoHS Directive compliant ●Tin-plating pin terminals
MXUDP		Collector current I_C ..... **150** A Collector-emitter voltage V_{CES} ..... **1200** V Maximum junction temperature T_{vjmax} ..... **175** °C ●Flat base type ●Copper base plate (Nickel-plating) ●RoHS Directive compliant ●Tin-plating pressfit terminals
CIB (Converter+Inverter+Chopper Brake)		●UL Recognized under UL1557, File No. E323585

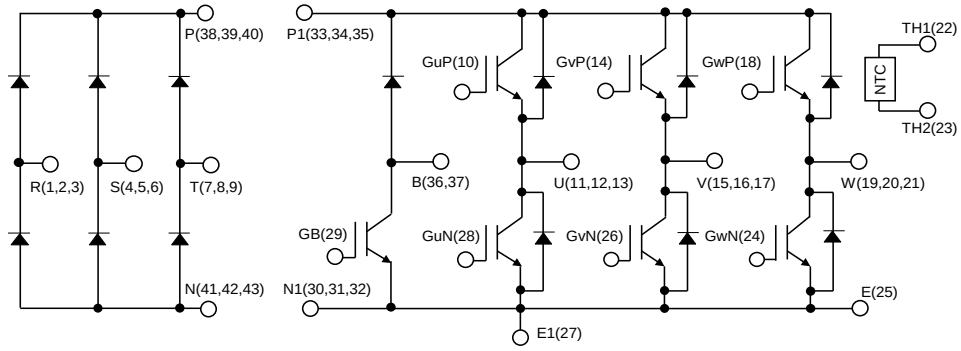
APPLICATION

AC Motor Control, Motion/Servo Control, Power supply, etc.

OPTION (Below options are available.)

●PC-TIM (Phase Change Thermal Interface Material) pre-apply (Note10)

INTERNAL CONNECTION



Terminal code

1	R	16	V	31	N1
2	R	17	V	32	N1
3	R	18	GwP	33	P1
4	S	19	W	34	P1
5	S	20	W	35	P1
6	S	21	W	36	B
7	T	22	TH1	37	B
8	T	23	TH2	38	P
9	T	24	GwN	39	P
10	GuP	25	E	40	P
11	U	26	GvN	41	N
12	U	27	E1	42	N
13	U	28	GuN	43	N
14	GvP	29	GB		
15	V	30	N1		

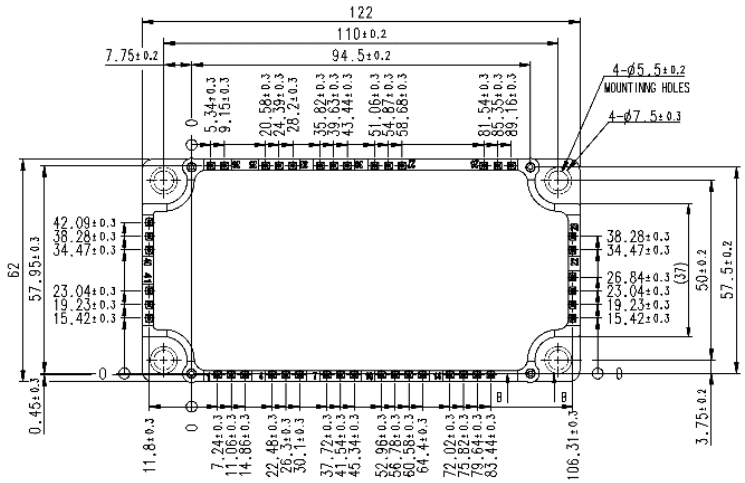
<IGBT Modules>

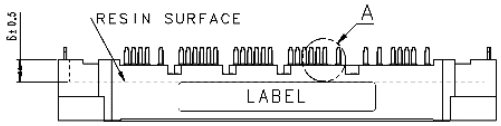
CM150MXUD-24T/CM150MXUDP-24T

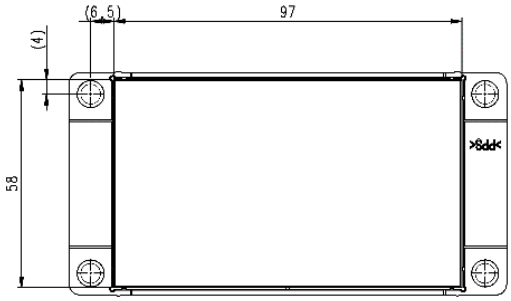
HIGH POWER SWITCHING USE
INSULATED TYPE

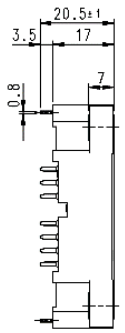
OUTLINE DRAWING **Dimension in mm**

MXUD

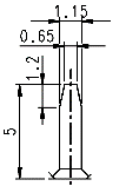




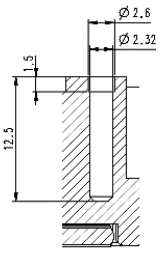




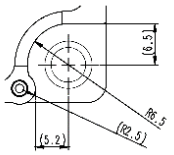
SECTION A



SECTION B



MOUNTING HOLES



Tolerance otherwise specified

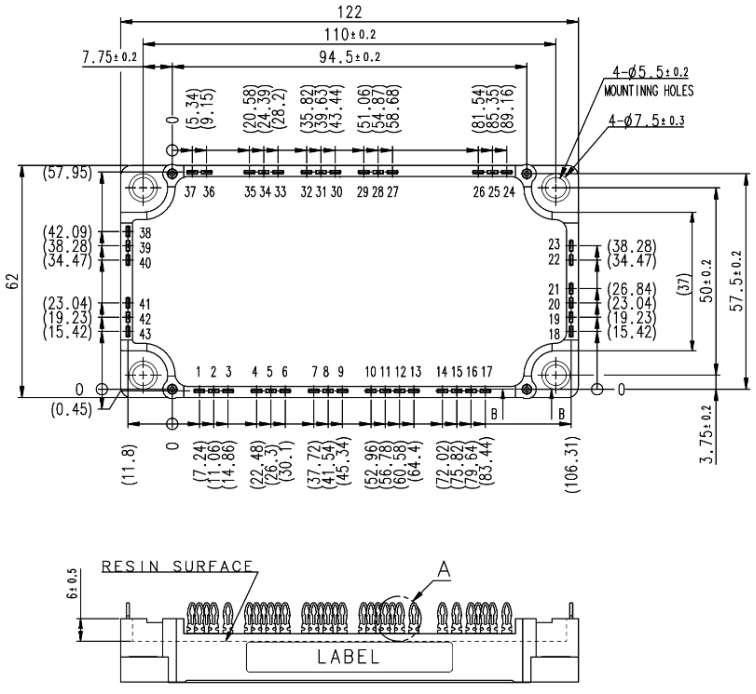
Division of Dimension		Tolerance
0.5	to 3	±0.2
over 3	to 6	±0.3
over 6	to 30	±0.5
over 30	to 120	±0.8
over 120	to 400	±1.2

CM150MXUD-24T/CM150MXUDP-24T

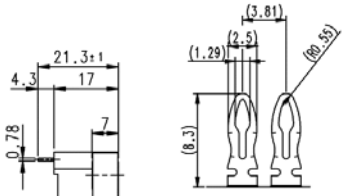
HIGH POWER SWITCHING USE
INSULATED TYPE

OUTLINE DRAWING **Dimension in mm**

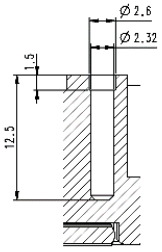
MXUDP



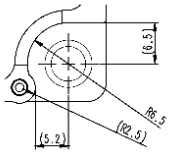
TERMINAL

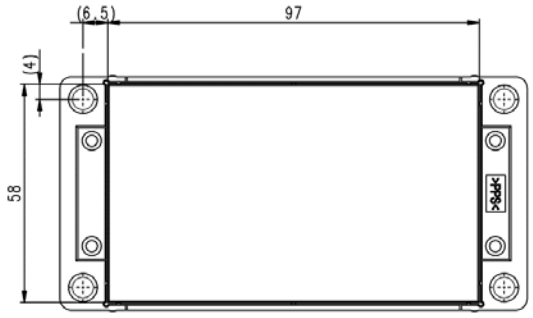


SECTION A

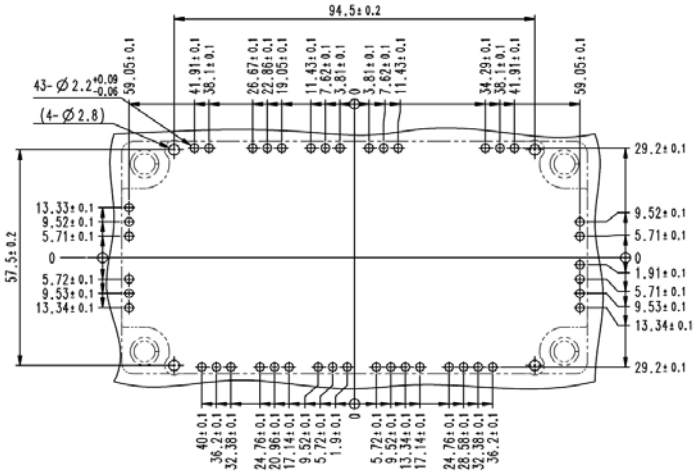


MOUNTING HOLES





PCB DRILL HOLE PATTERN



Tolerance otherwise specified

Division of Dimension		Tolerance
0.5	to 3	±0.2
over 3	to 6	±0.3
over 6	to 30	±0.5
over 30	to 120	±0.8
over 120	to 400	±1.2

MAXIMUM RATINGS (T_{vj}=25 °C, unless otherwise specified)

INVERTER PART IGBT/FWD

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, T_C=112 °C (Note2, 4)	150	A
I_{CRM}		Pulse, Repetitive (Note3)	300	
P_{tot}	Total power dissipation	T_C=25 °C (Note2, 4)	760	W
I_E (Note1)	Emitter current	DC (Note2)	150	A
I_{ERM} (Note1)		Pulse, Repetitive (Note3)	300	
T_{vjmax}	Maximum junction temperature	Instantaneous event (overload) (Note10)	175	°C

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions	Rating	Unit
V_{CES}	Collector-emitter voltage	G-E short-circuited	1200	V
V_{GES}	Gate-emitter voltage	C-E short-circuited	± 20	V
I_C	Collector current	DC, T_C=119 °C (Note2, 4)	100	A
I_{CRM}		Pulse, Repetitive (Note3)	200	
P_{tot}	Total power dissipation	T_C=25 °C (Note2, 4)	565	W
V_{RRM}	Repetitive peak reverse voltage	G-E short-circuited	1200	V
I_F	Forward current	DC (Note2)	75	A
I_{FRM}		Pulse, Repetitive (Note3)	150	
T_{vjmax}	Maximum junction temperature	Instantaneous event (overload) (Note10)	175	°C

CONVERTER PART DIODE

Symbol	Item	Conditions		Rating	Unit
V_{RRM}	Repetitive peak reverse voltage	-		1600	V
E_a	Recommended AC input voltage	RMS		440	V
I_o	DC output current	3-phase full wave rectifying, T_C=125 °C (Note4)		150	A
I_{FSM}	Surge forward current	The sine half wave 1 cycle peak value,	T_{vj}=25 °C	1920	A
		f=60 Hz, non-repetitive	T_{vj}=150 °C	1536	
I^2t	Current square time	Value for one cycle of surge current	T_{vj}=25 °C	15360	A^2s
			T_{vj}=150 °C	9830	
T_{vjmax}	Maximum junction temperature	Instantaneous event (overload) (Note10)		150	°C

MODULE

Symbol	Item	Conditions	Rating	Unit
V_{isol}	Isolation voltage	Terminals to base plate, RMS, f=60 Hz, AC 1 min	2500	V
T_{Cmax}	Maximum case temperature	(Note4, 10)	125	°C
T_{vjop}	Operating junction temperature	Continuous operation (under switching) (Note10)	-40 ~ +150	°C
T_{stg}	Storage temperature	-	-40 ~ +125	

ELECTRICAL CHARACTERISTICS (T_{vj}=25 °C, unless otherwise specified)

INVERTER PART IGBT/FWD

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{CES}	Collector-emitter cut-off current	V_{CE}=V_{CES}, G-E short-circuited		-	-	1.0	mA
I_{GES}	Gate-emitter leakage current	V_{GE}=V_{GES}, C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I_C=15 mA, V_{CE}=10 V		5.4	6.0	6.6	V
V_{CEsat} (Terminal)	Collector-emitter saturation voltage	I_C=150 A, V_{GE}=15 V, Refer to the figure of test circuit (Note5)	T_{vj}=25 °C	-	1.75	2.20	V
			T_{vj}=125 °C	-	2.10	-	
			T_{vj}=150 °C	-	2.20	-	
V_{CEsat} (Chip)		I_C=150 A, V_{GE}=15 V, (Note5)	T_{vj}=25 °C	-	1.50	1.75	V
			T_{vj}=125 °C	-	1.70	-	
			T_{vj}=150 °C	-	1.75	-	
C_{ies}	Input capacitance	V_{CE}=10 V, G-E short-circuited		-	-	36.4	nF
C_{oes}	Output capacitance			-	-	1.0	
C_{res}	Reverse transfer capacitance			-	-	0.4	
Q_G	Gate charge	V_{CC}=600 V, I_C=150 A, V_{GE}=15 V		-	1.13	-	μC
$t_{d(on)}$	Turn-on delay time	V_{CC}=600 V, I_C=150 A, V_{GE}=±15 V, R_G=0 Ω, Inductive load		-	-	500	ns
t_r	Rise time			-	-	150	
$t_{d(off)}$	Turn-off delay time			-	-	500	
t_f	Fall time			-	-	400	
V_{EC} (Note1) (Terminal)	Emitter-collector voltage	I_E=150 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T_{vj}=25 °C	-	1.90	2.45	V
			T_{vj}=125 °C	-	2.15	-	
			T_{vj}=150 °C	-	2.20	-	
V_{EC} (Note1) (Chip)		I_E=150 A, G-E short-circuited, (Note5)	T_{vj}=25 °C	-	1.55	2.00	V
			T_{vj}=125 °C	-	1.55	-	
			T_{vj}=150 °C	-	1.55	-	
t_{rr} (Note1)	Reverse recovery time	V_{CC}=600 V, I_E=150 A, V_{GE}=±15 V, R_G=0 Ω, Inductive load		-	-	400	ns
Q_{rr} (Note1)	Reverse recovery charge			-	15.0	-	μC
E_{on}	Turn-on switching energy per pulse	V_{CC}=600 V, I_C=I_E=150 A, V_{GE}=±15 V, R_G=0 Ω, T_{vj}=150 °C, Inductive load		-	14.8	-	mJ
E_{off}	Turn-off switching energy per pulse			-	15.3	-	
E_{rr} (Note1)	Reverse recovery energy per pulse			-	8.6	-	mJ
r_g	Internal gate resistance	Per switch		-	2.0	-	Ω

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{CES}	Collector-emitter cut-off current	V_{CE}=V_{CES}, G-E short-circuited		-	-	1.0	mA
I_{GES}	Gate-emitter leakage current	V_{GE}=V_{GES}, C-E short-circuited		-	-	0.5	μA
$V_{GE(th)}$	Gate-emitter threshold voltage	I_C=10 mA, V_{CE}=10 V		5.4	6.0	6.6	V
V_{CEsat} (Terminal)	Collector-emitter saturation voltage	I_C=100 A, V_{GE}=15 V, Refer to the figure of test circuit (Note5)	T_{vj}=25 °C	-	1.75	2.20	V
			T_{vj}=125 °C	-	2.10	-	
			T_{vj}=150 °C	-	2.20	-	
V_{CEsat} (Chip)		I_C=100 A, V_{GE}=15 V, (Note5)	T_{vj}=25 °C	-	1.55	1.80	V
			T_{vj}=125 °C	-	1.75	-	
			T_{vj}=150 °C	-	1.80	-	
C_{ies}	Input capacitance	V_{CE}=10 V, G-E short-circuited		-	-	24.2	nF
C_{oes}	Output capacitance			-	-	0.7	
C_{res}	Reverse transfer capacitance			-	-	0.3	
Q_G	Gate charge	V_{CC}=600 V, I_C=100 A, V_{GE}=15 V		-	0.75	-	μC
$t_{d(on)}$	Turn-on delay time	V_{CC}=600 V, I_C=100 A, V_{GE}=±15 V, R_G=3.9 Ω, Inductive load		-	-	300	ns
t_r	Rise time			-	-	150	
$t_{d(off)}$	Turn-off delay time			-	-	500	
t_f	Fall time			-	-	400	

ELECTRICAL CHARACTERISTICS (cont.; T_{vj}=25 °C, unless otherwise specified)

BRAKE PART IGBT/DIODE

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
E_{on}	Turn-on switching energy per pulse	V_{CC}=600 V, V_{GE}=±15 V,	I_C=100A,R_G=3.9Ω	-	4.1	-	mJ
E_{off}	Turn-off switching energy per pulse	T_{vj}=150 °C, Inductive load		-	10.6	-	
E_{rr}	Reverse recovery energy per pulse		I_E=100A,R_G=3.9Ω	-	7.8	-	
r_g	Internal gate resistance	-		-	0	-	Ω
I_{RRM}	Reverse current	V_R=V_{RRM}, G-E short-circuited		-	-	1.0	mA
V_F (Terminal)	Forward voltage	I_F=75 A, G-E short-circuited, Refer to the figure of test circuit (Note5)	T_{vj}=25 °C	-	1.80	2.40	V
			T_{vj}=125 °C	-	2.00	-	
			T_{vj}=150 °C	-	2.05	-	
V_F (Chip)		I_F=75 A, G-E short-circuited, (Note5)	T_{vj}=25 °C	-	1.65	2.10	V
			T_{vj}=125 °C	-	1.65	-	
			T_{vj}=150 °C	-	1.65	-	
t_{rr}	Reverse recovery time	V_{CC}=600 V, I_F=75 A, V_{GE}=±15 V,		-	-	400	ns
Q_{rr}	Reverse recovery charge	R_G=5.6 Ω, Inductive load		-	7.5	-	μC

CONVERTER PART DIODE

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
I_{RRM}	Repetitive peak reverse current	V_R=V_{RRM}, T_{vj}=150 °C		-	-	20	mA
V_F (Terminal)	Forward voltage	I_F=150 A	T_{vj}=25 °C	-	1.40	1.85	V
			T_{vj}=150 °C	-	1.30	-	
V_F (chip)			T_{vj}=25 °C	-	1.15	1.40	
			T_{vj}=150 °C	-	1.10	-	

NTC THERMISTOR PART

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
R_{25}	Zero-power resistance	T_C=25 °C (Note4)	4.85	5.00	5.15	kΩ
ΔR/R	Deviation of resistance	R_{100}=493 Ω, T_C=100 °C (Note4)	-7.3	-	+7.8	%
$B_{(25/50)}$	B-constant	Approximate by equation (Note6)	-	3375	-	K
P_{25}	Power dissipation	T_C=25 °C (Note4)	-	-	10	mW

THERMAL RESISTANCE CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
$R_{th(j-c)Q}$	Thermal resistance	Junction to case, per Inverter IGBT (Note4)		-	-	197	K/kW
$R_{th(j-c)D}$		Junction to case, per Inverter FWD (Note4)		-	-	391	
$R_{th(j-c)Q}$		Junction to case, Brake IGBT (Note4)		-	-	264	
$R_{th(j-c)D}$		Junction to case, Brake DIODE (Note4)		-	-	628	
$R_{th(j-c)D}$		Junction to case, per Converter DIODE (Note4)				324	
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, per 1 module,	Thermal grease applied (Note4, 7, 10)	-	11.5	-	K/kW
			PC-TIM applied (Note4, 8, 10)	-	3.1	-	

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions		Limits			Unit
				Min.	Typ.	Max.	
M_s	Mounting torque	Mounting to heat sink	M 5 screw	2.5	3.0	3.5	N·m
d_s	Creepage distance	Solder pin type(MXUD)	Terminal to terminal	11.7	-	-	mm
			Terminal to base plate	18.3	-	-	
		Pressfit pin type(MXUDP)	Terminal to terminal	5.1	-	-	
			Terminal to base plate	15.8	-	-	
d_a	Clearance	Solder pin type(MXUD)	Terminal to terminal	6.5	-	-	
			Terminal to base plate	18.1	-	-	
		Pressfit pin type(MXUDP)	Terminal to terminal	5.0	-	-	
			Terminal to base plate	15.8	-	-	
e_c	Flatness of base plate	On the centerline X, Y (Note9)		±0	-	+200	μm
m	mass	-		-	270	-	g

RECOMMENDED OPERATING CONDITIONS

Symbol	Item	Conditions	Limits			Unit
			Min.	Typ.	Max.	
V_{CC}	(DC) Supply voltage	Applied across P-N(P1-N1) terminals	-	600	850	V
V_{GEon}	Gate (-emitter drive) voltage	Applied across G*P-*/G*N-E/GB-E terminals (*=U,V,W)	13.5	15.0	16.5	V
R_G	External gate resistance	Inverter IGBT, Per switch	0	-	20	Ω
		Brake IGBT	3.9	-	40	

*: This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU and (EU) 2015/863.

Note1. Represent ratings and characteristics of the anti-parallel, emitter-collector free-wheeling diode (FWD).

2. Junction temperature (T_{vj}) should not increase beyond T_{vjmax} rating.

3. Pulse width and repetition rate should be such that the device junction temperature (T_{vj}) dose not exceed T_{vjmax} rating.

4. Case temperature (T_C) and heat sink temperature (T_S) are defined on the each surface (mounting side) of base plate and heat sink just under the chips. Refer to the figure of chip location.

5. Pulse width and repetition rate should be such as to cause negligible temperature rise. Refer to the figure of test circuit.

6. $B_{(25/50)} = \ln(\frac{R_{25}}{R_{50}})/(\frac{1}{T_{25}} - \frac{1}{T_{50}})$

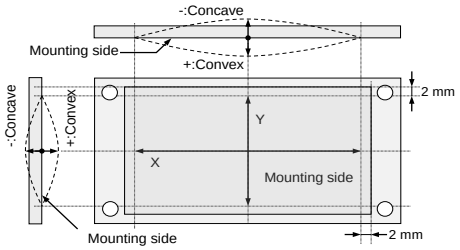
   R_{25}: resistance at absolute temperature T_{25} [K]; T_{25}=25 [°C]+273.15=298.15 [K]

   R_{50}: resistance at absolute temperature T_{50} [K]; T_{50}=50 [°C]+273.15=323.15 [K]

7. Typical value is measured by using thermally conductive grease of λ=0.9 W/(m·K)/$D_{(C-S)}$=50 μm.

8. Typical value is measured by using PC-TIM of λ=3.4 W/(m·K)/$D_{(C-S)}$=50 μm.

9. The base plate (mounting side) flatness measurement points (X, Y) are shown in the following figure.



10. Long term performance related to thermal conductive grease and PC-TIM (including but not limited to aspects such as the increase of thermal resistance due to pumping out, etc.) should be verified under your specific application conditions. Each temperature condition ($T_{vj\,max}$, $T_{vj\,op}$, $T_{C\,max}$) must be maintained below the maximum rated temperature throughout consideration of the temperature rise even for long term usage.

11. Use the following screws when mounting the printed circuit board (PCB) on the standoffs.

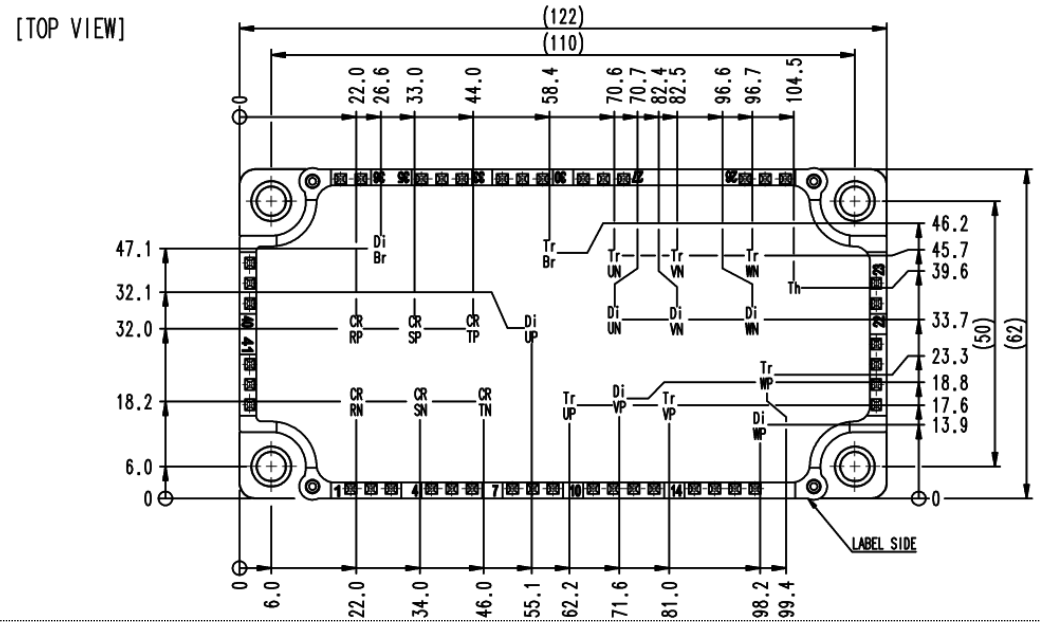
PCB thickness : t1.6

	Type	Manufacturer	Size	Tightening torque (N・m)	Recommended tightening method
(1)	PT®	EJOT	K25×8	0.55 ± 0.055	by handwork (equivalent to 30 rpm by mechanical screw driver) ~ 600 rpm (by mechanical screw driver)
(2)	PT®		K25×10	0.75 ± 0.075 N・m	
(3)	DELTA PT®		25×8	0.55 ± 0.055 N・m	
(4)	DELTA PT®		25×10	0.75 ± 0.075 N・m	
(5)	B1 tapping screw	-	φ2.6×10	0.75 ± 0.075 N・m	
			φ2.6×12		

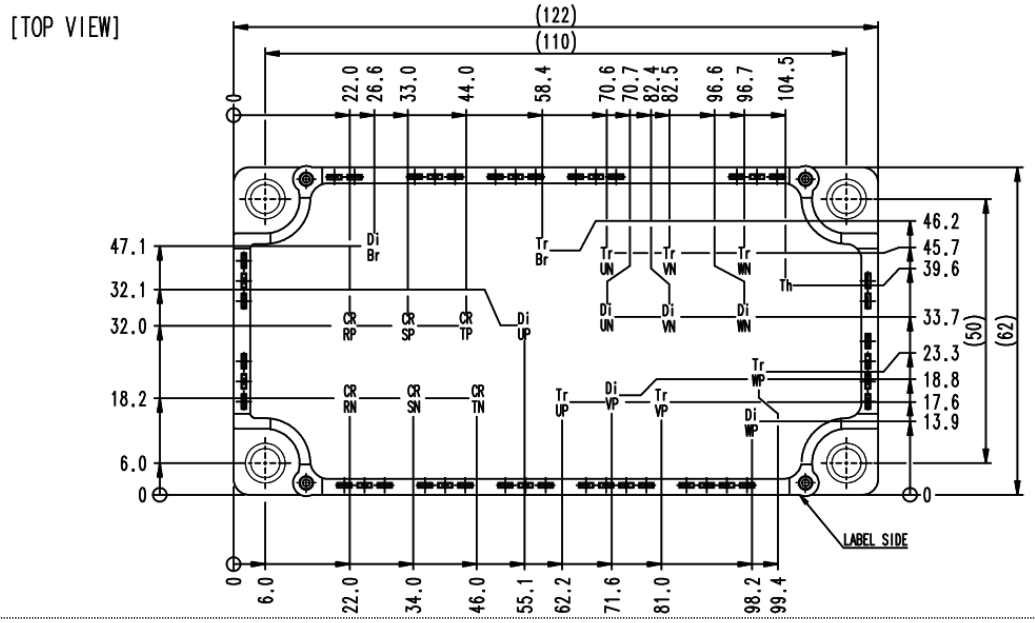
CHIP LOCATION (Top view)

Dimension in mm, tolerance: ±1 mm

MXUD

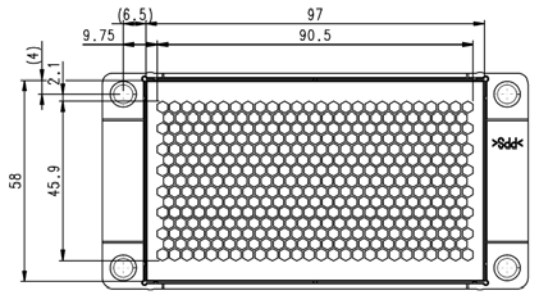
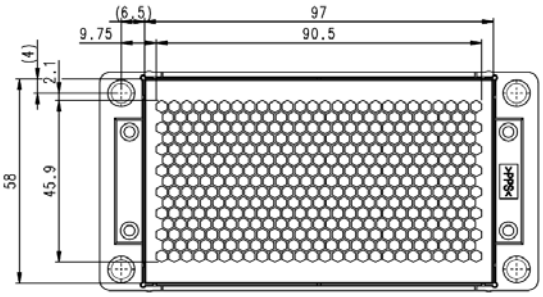


MXUDP

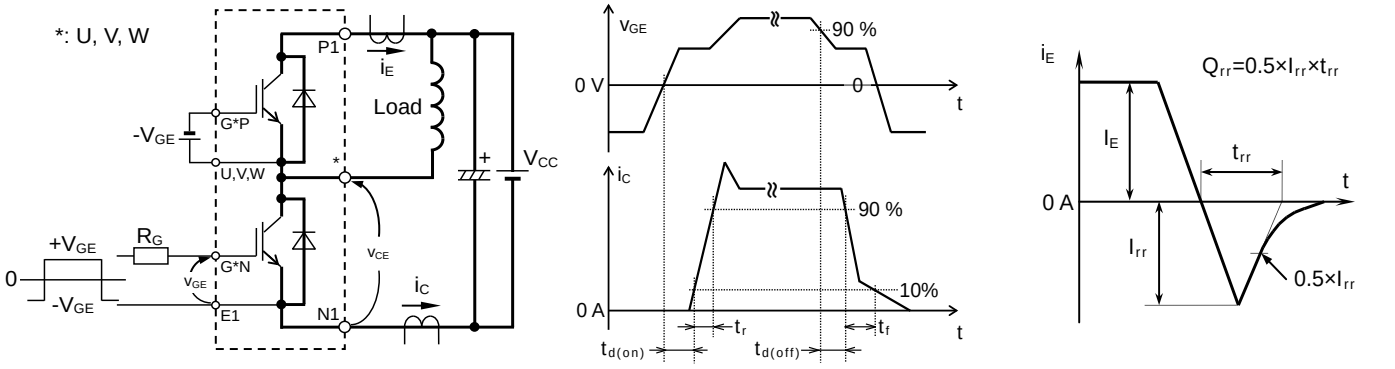


Tr*P/Tr*N/TrBr: IGBT, Di*P/Di*N: DIODE (*=U/V/W), DiBr: BRAKE DIODE,
CR*P/CR*N: CONVERTER DIODE (*=R/S/T), Th: NTC thermistor

Option: PC-TIM applied baseplate outline

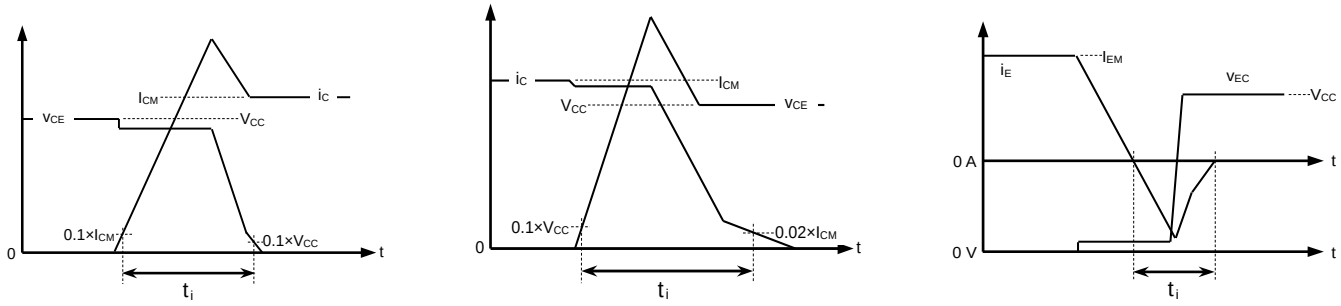
MXUD	MXUDP
	

TEST CIRCUIT AND WAVEFORMS



Switching characteristics test circuit and waveforms

t_{rr}, Q_{rr} characteristics test waveform



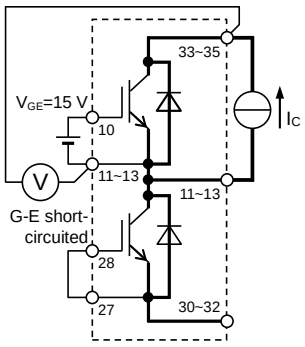
IGBT Turn-on switching energy

IGBT Turn-off switching energy

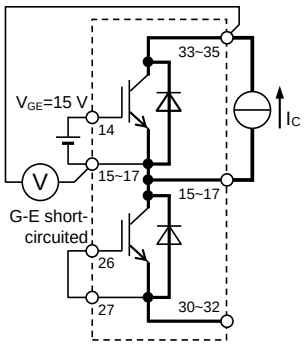
FWD Reverse recovery energy

Switching energy and Reverse recovery energy test waveforms (Integral time instruction drawing)

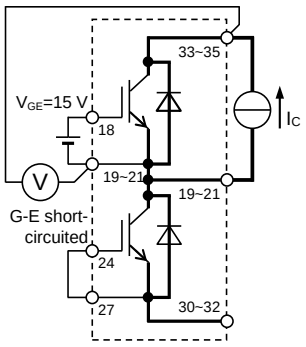
TEST CIRCUIT



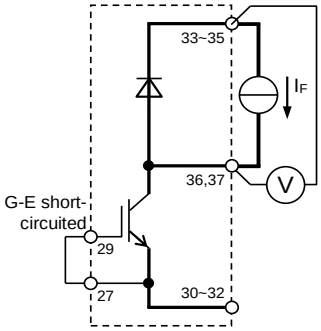
TrUP



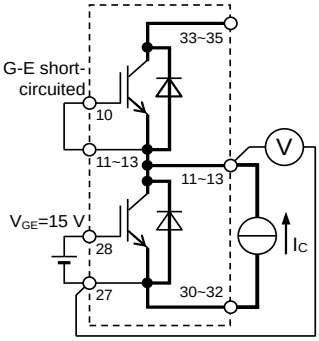
TrVP



TrWP

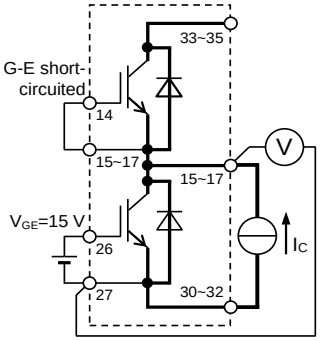


Brake DIODE



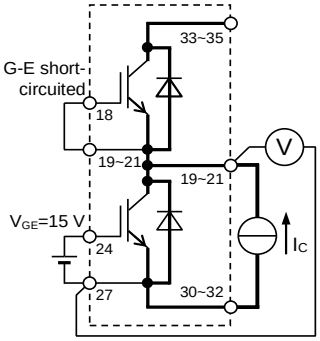
TrUN

Gate-emitter short-circuited: GVP-V, GVN-E1, GWP-W, GWN-E1, GB-E1



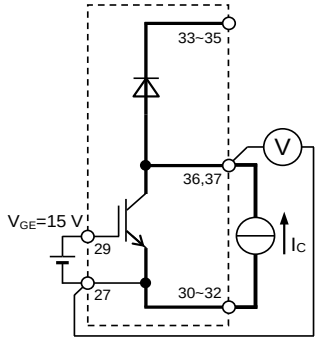
TrVN

Gate-emitter short-circuited: GUP-U, GUN-E1, GWP-W, GWN-E1, GB-E1



TrWN

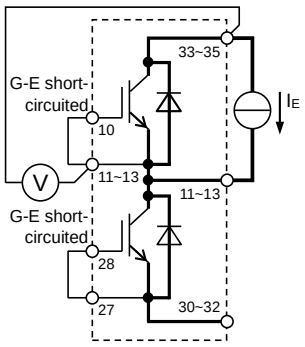
Gate-emitter short-circuited: GUP-U, GUN-E1, GVP-V, GVN-E1, GB-E1



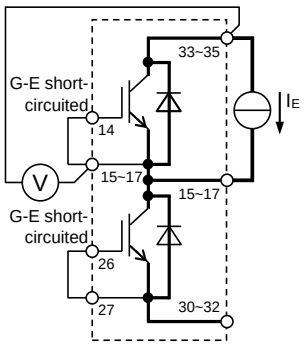
Brake IGBT

Gate-emitter short-circuited: GUP-U, GUN-E1, GVP-V, GVN-E1, GWP-W, GWN-E1

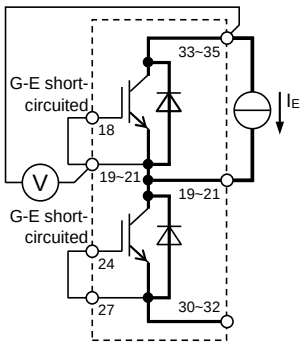
V_{CEsat} /BRAKE DIODE V_F characteristics test circuit



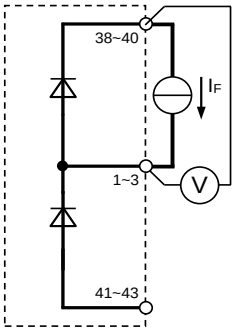
DiUP

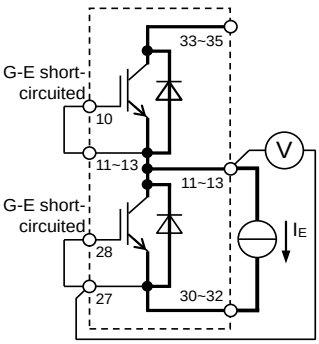


DiVP



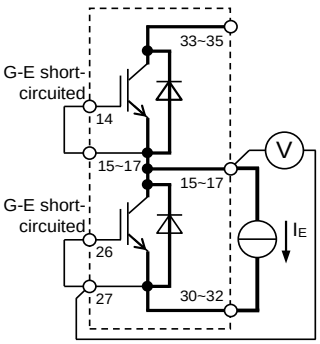
DiWP





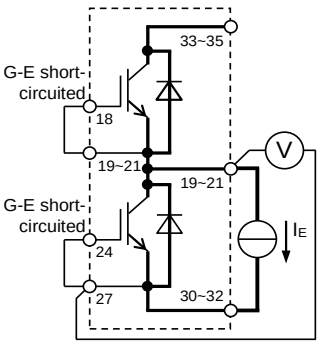
DiUN

Gate-emitter short-circuited: GVP-V, GVN-E1, GWP-W, GWN-E1, GB-E1



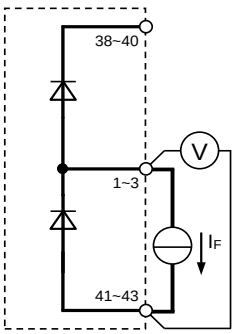
DiVN

Gate-emitter short-circuited: GUP-U, GUN-E1, GWP-W, GWN-E1, GB-E1



DiWN

Gate-emitter short-circuited: GUP-U, GUN-E1, GVP-V, GVN-E1, GB-E1



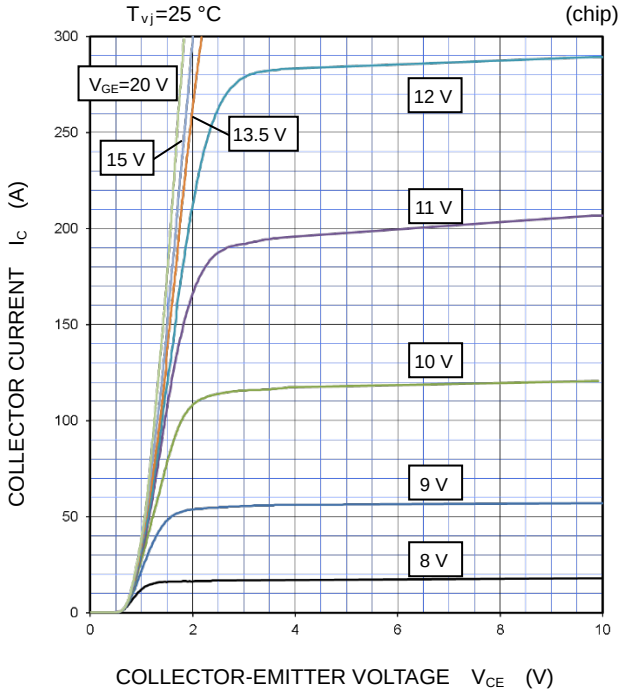
CONVERTER DIODE (ex.phase-R)

V_{EC} / CONVERTER DIODE V_F characteristics test circuit

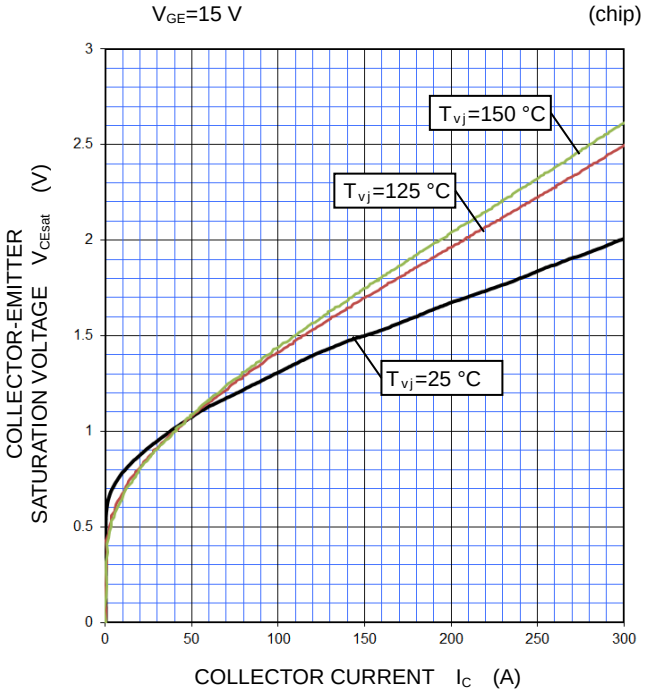
PERFORMANCE CURVES

INVERTER PART

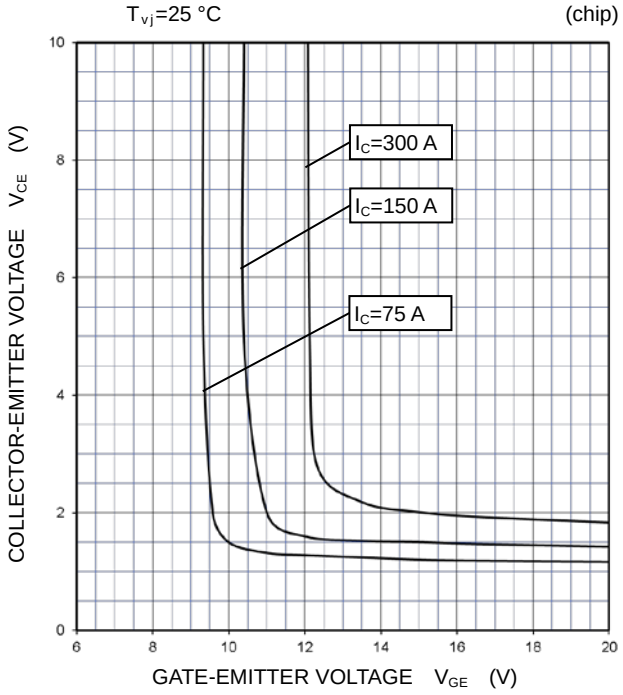
OUTPUT CHARACTERISTICS (TYPICAL)



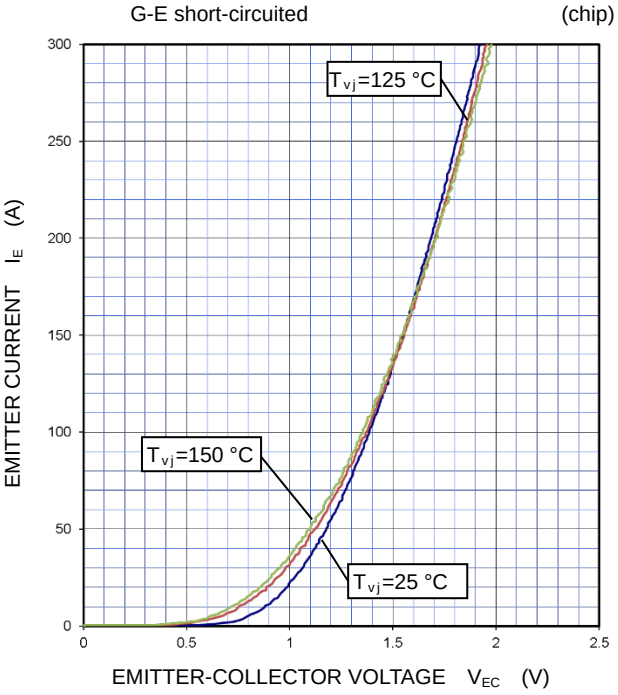
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)



FREE WHEELING DIODE FORWARD CHARACTERISTICS (TYPICAL)

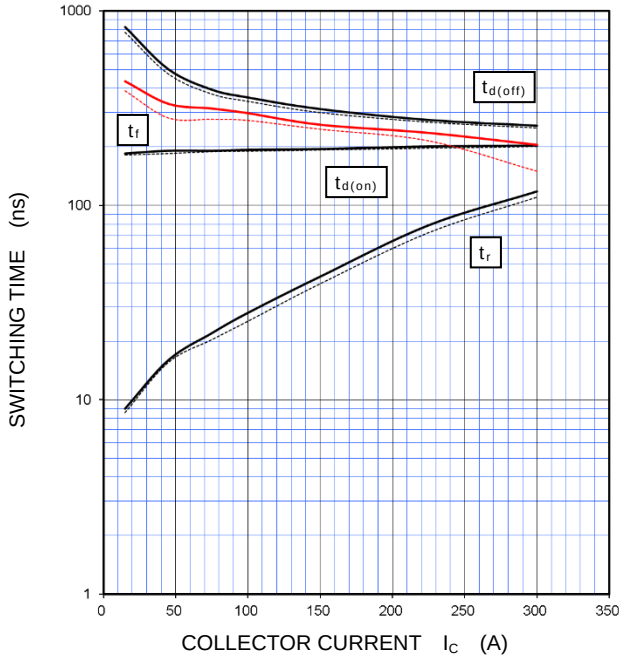


PERFORMANCE CURVES

INVERTER PART

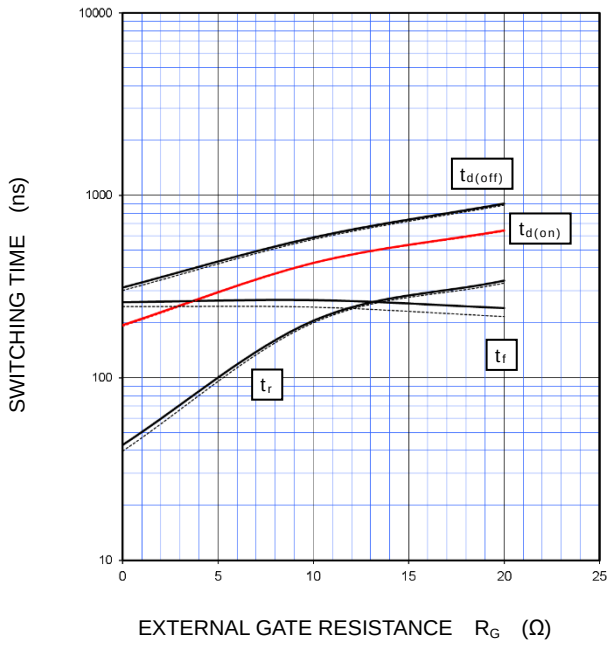
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, R_G=0 Ω, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C



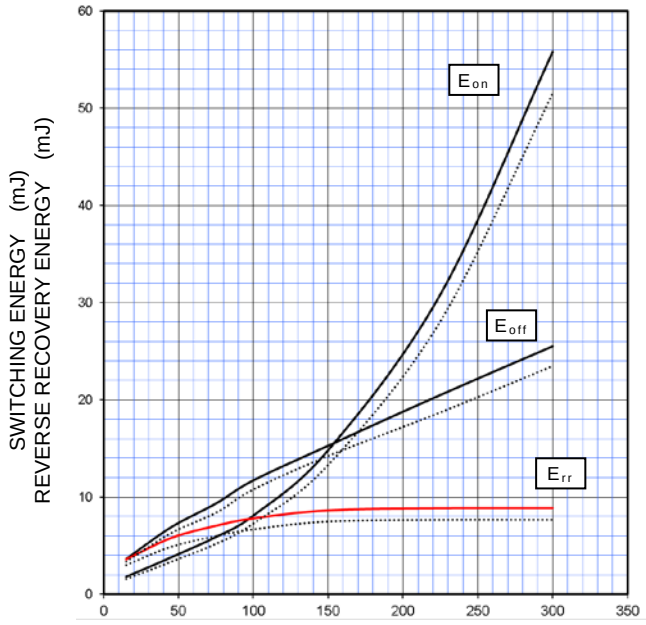
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, I_C=150 A, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C



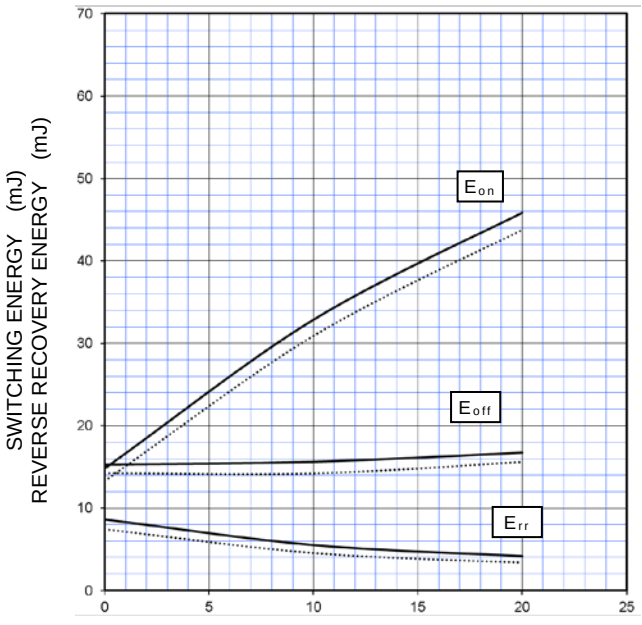
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, R_G=0 Ω, V_{GE}=±15 V, INDUCTIVE LOAD,
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C, PER PULSE



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, I_C/I_E=150 A, V_{GE}=±15 V, INDUCTIVE LOAD,
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C, PER PULSE

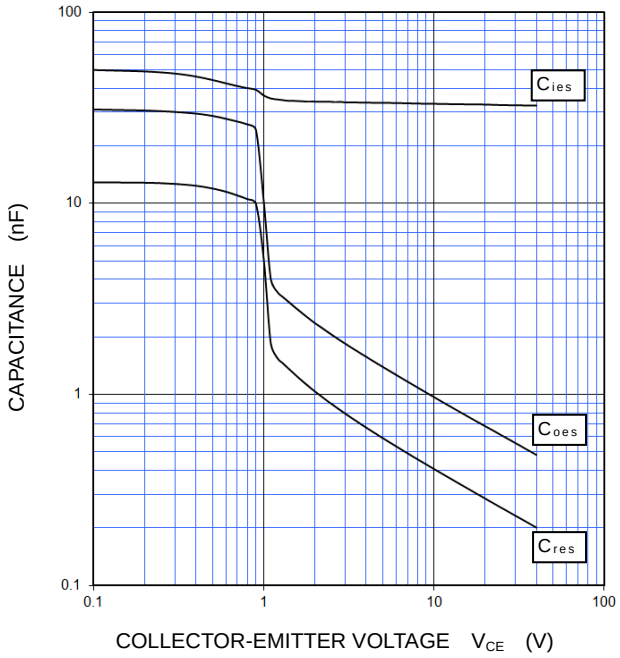


PERFORMANCE CURVES

INVERTER PART

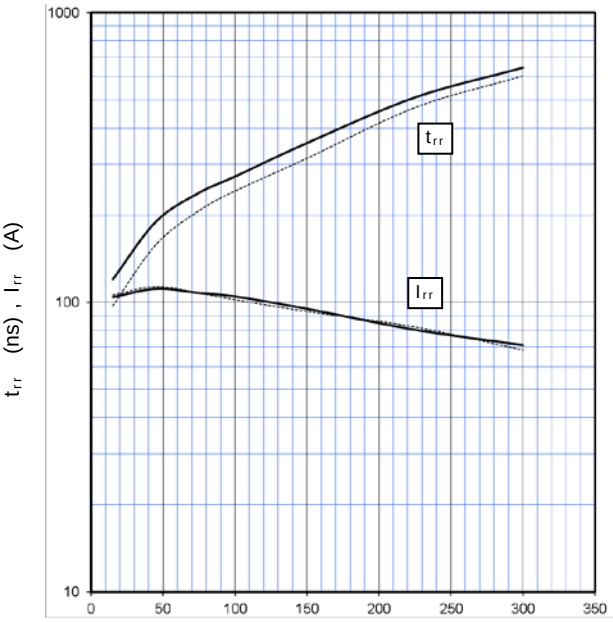
CAPACITANCE CHARACTERISTICS (TYPICAL)

G-E short-circuited, T_{vj}=25 °C



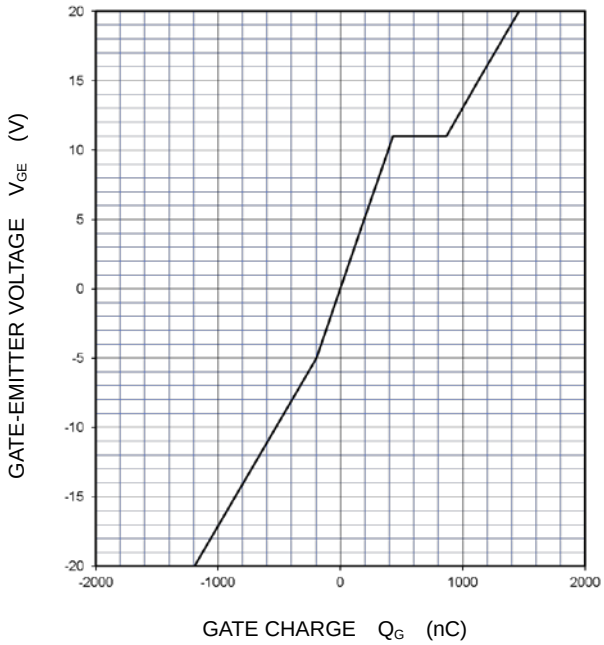
FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, R_G=0 Ω, V_{GE}=±15 V, INDUCTIVE LOAD
———: T_j=150 °C, - - - - -: T_j=125 °C



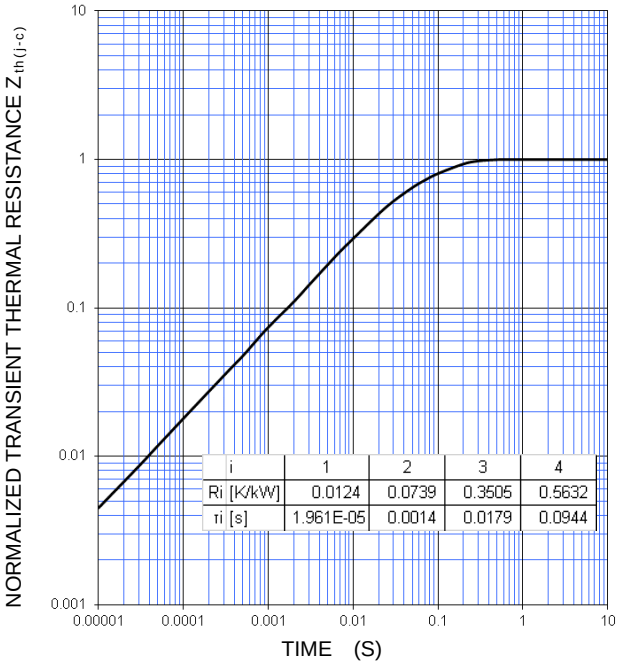
GATE CHARGE CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, I_C=150 A, T_{vj}=25 °C



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

Single pulse, T_C=25 °C
$R_{th(j-c)Q}$=197 K/kW, $R_{th(j-c)D}$=391 K/kW



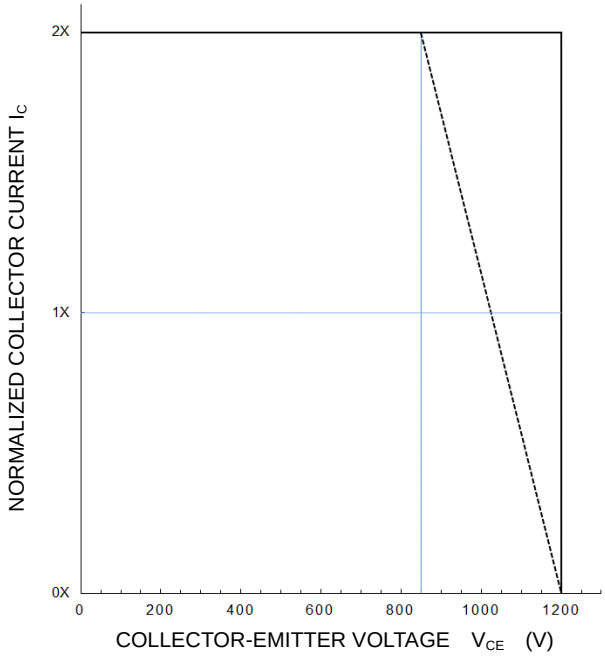
i	1	2	3	4
Ri [K/kW]	0.0124	0.0739	0.3505	0.5632
ri [s]	1.961E-05	0.0014	0.0179	0.0944

PERFORMANCE CURVES

INVERTER PART

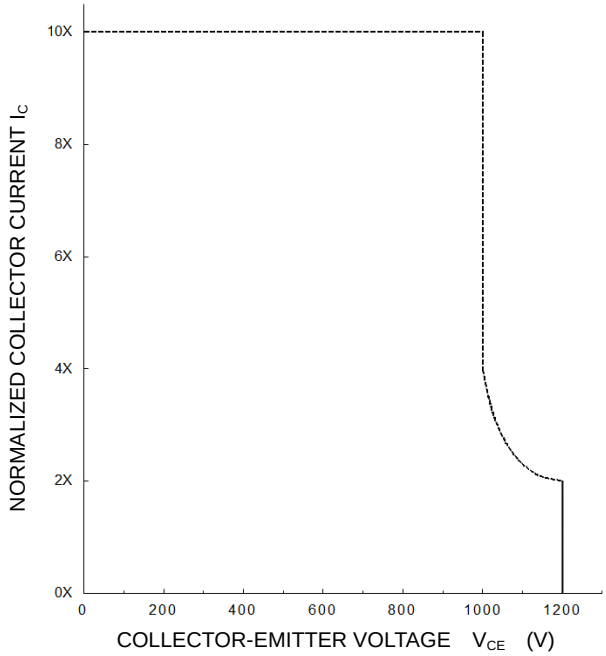
TURN-OFF SWITCHING SAFE OPERATIONG AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)

V_{CC}≤850 V, R_G=0~20 Ω, V_{GE}=±15 V,
————: T_{vj}=25~150 °C (Normal load operations (Continuous)
- - - - - -: T_{vj}=175 °C (Unusual load operations (Limited period)



SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)

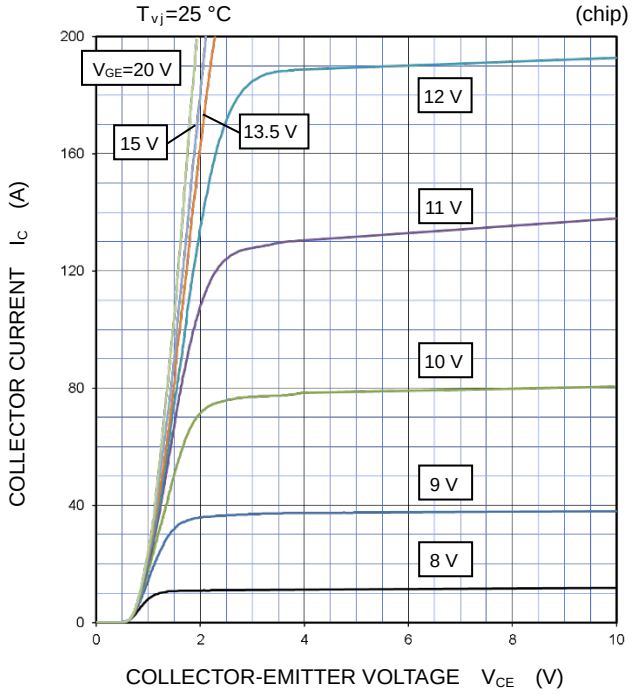
V_{CC}≤800 V, R_G=0~20 Ω, V_{GE}=±15 V,
T_{vj}= 25 ~ 150 °C, t_W≤8 μs, Non-Repetitive



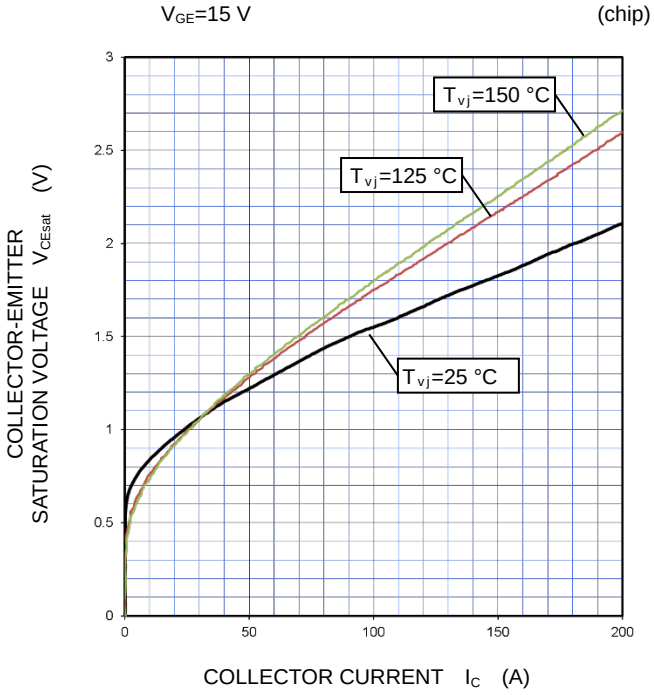
PERFORMANCE CURVES

BRAKE PART

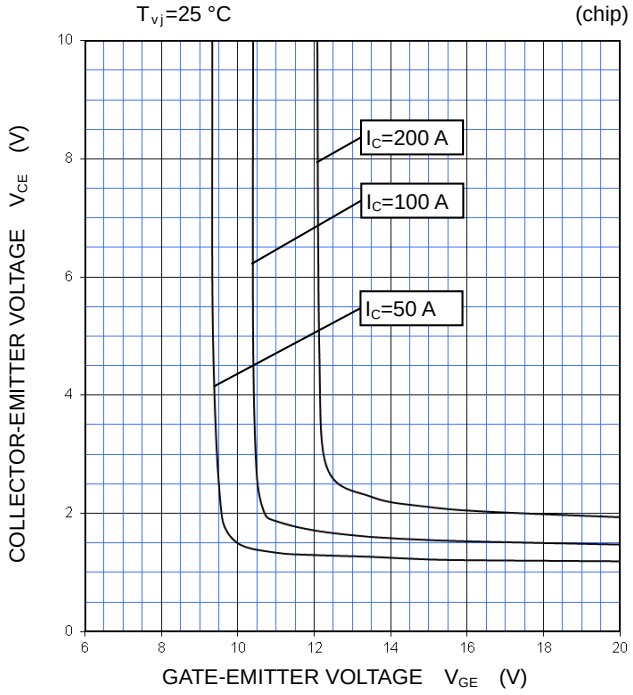
OUTPUT CHARACTERISTICS (TYPICAL)



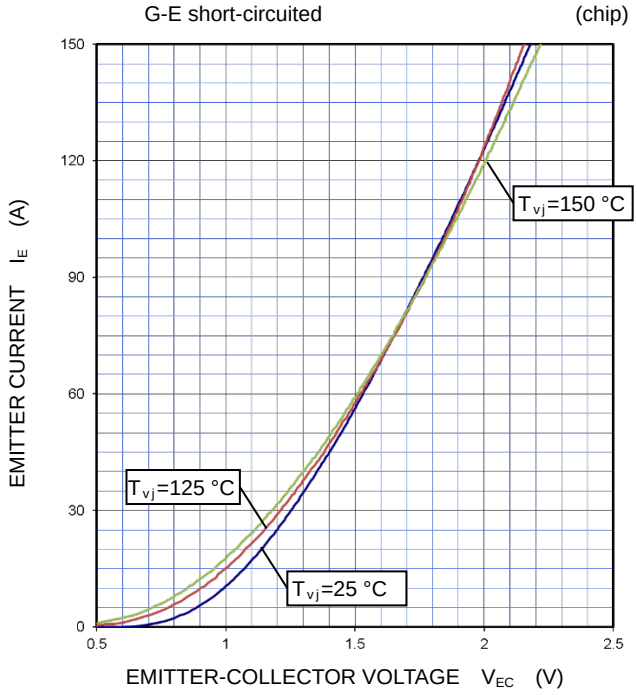
COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER VOLTAGE CHARACTERISTICS (TYPICAL)



DIODE FORWARD CHARACTERISTICS (TYPICAL)

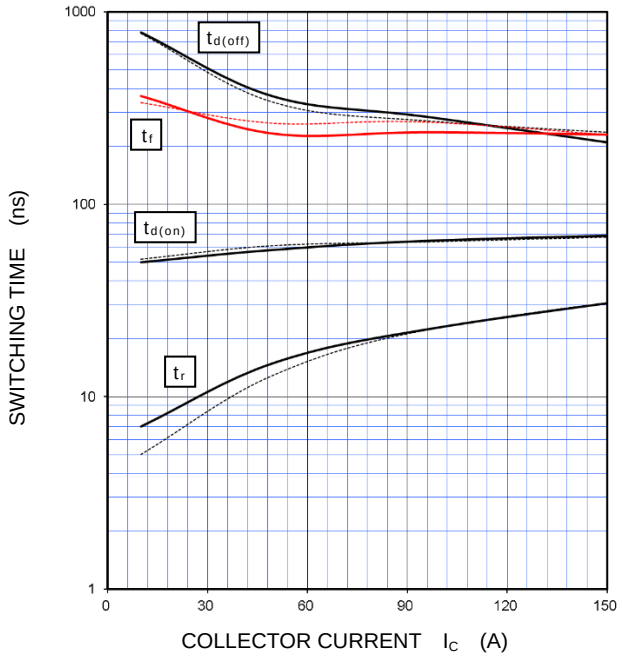


PERFORMANCE CURVES

BRAKE PART

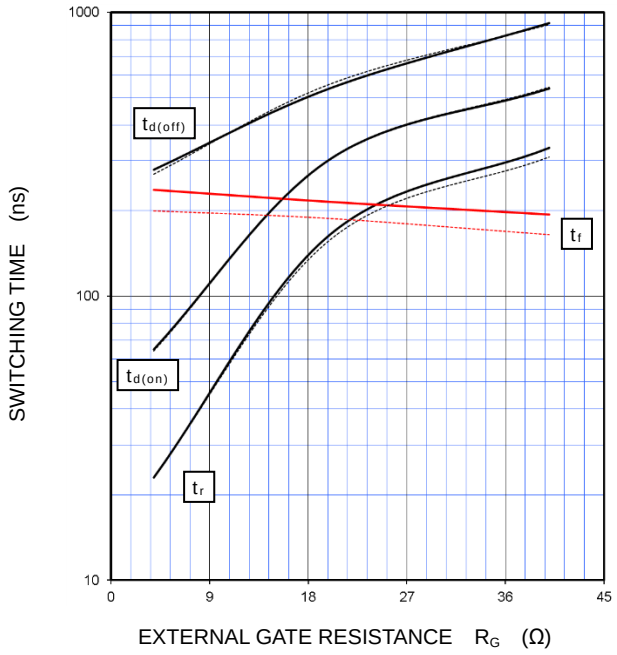
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, R_G=3.9 Ω, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C



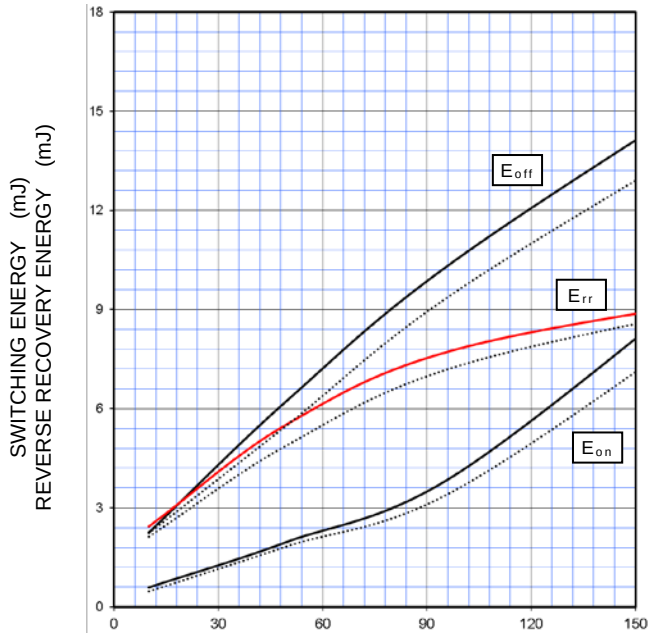
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, I_C=100 A, V_{GE}=±15 V, INDUCTIVE LOAD
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C



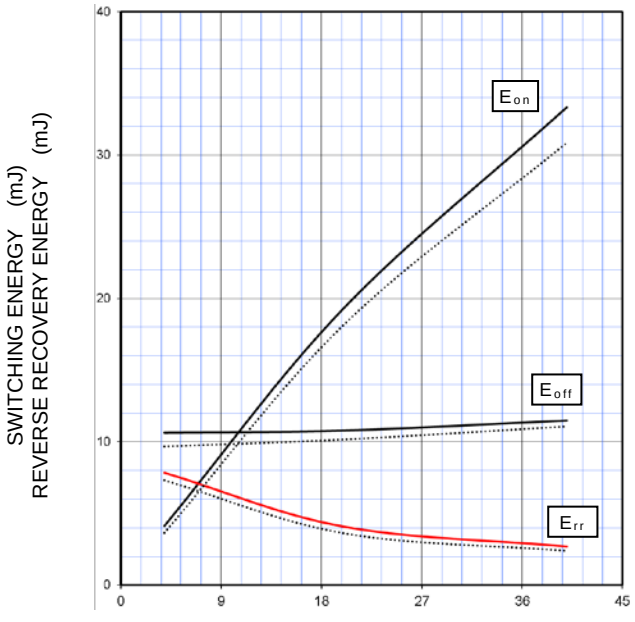
HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, R_G=3.9 Ω, V_{GE}=±15 V, INDUCTIVE LOAD,
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C, PER PULSE



HALF-BRIDGE SWITCHING CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, I_C/I_E=100 A, V_{GE}=±15 V, INDUCTIVE LOAD,
————: T_{vj}=150 °C, - - - - -: T_{vj}=125 °C, PER PULSE

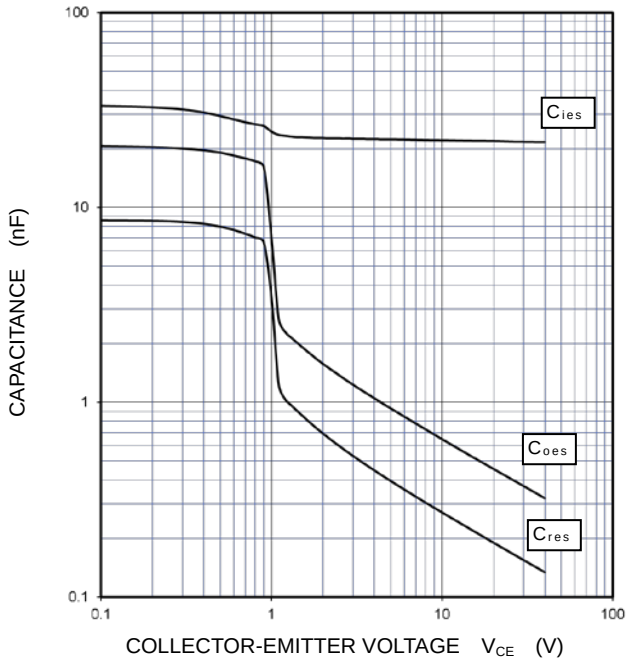


PERFORMANCE CURVES

BRAKE PART

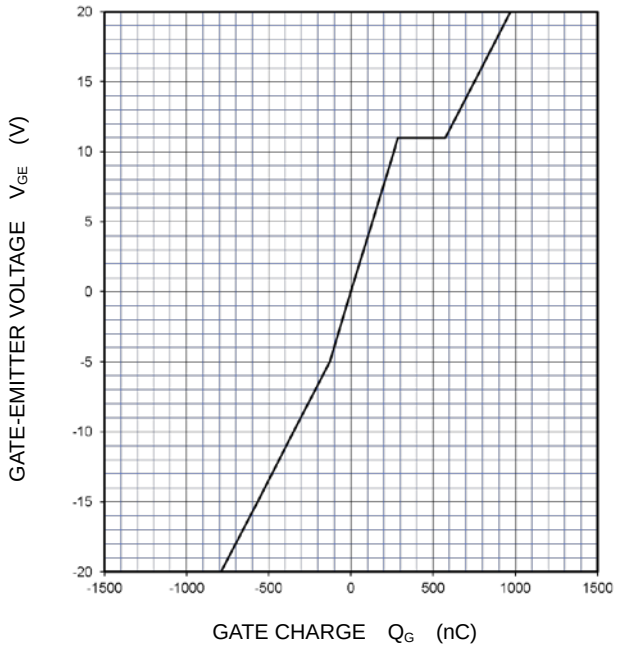
CAPACITANCE CHARACTERISTICS (TYPICAL)

G-E short-circuited, T_{vj}=25 °C



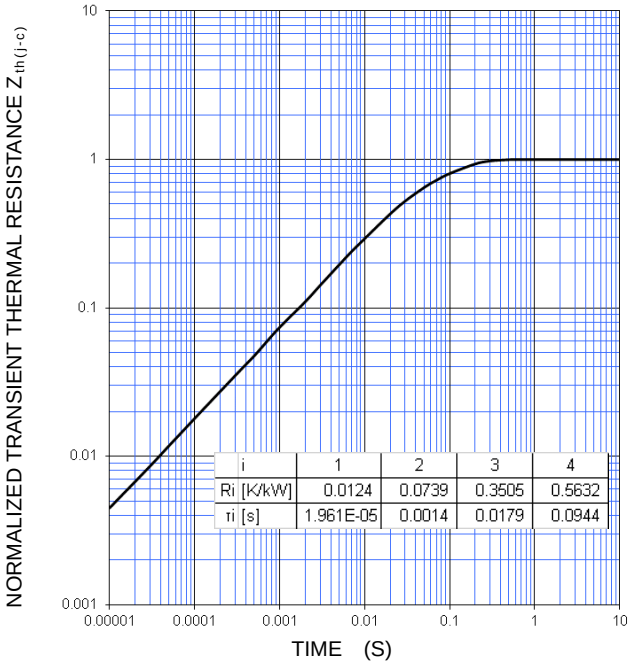
GATE CHARGE CHARACTERISTICS (TYPICAL)

V_{CC}=600 V, I_C=100 A, T_{vj}=25 °C



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

Single pulse, T_C=25 °C
$R_{th(j-c)Q}$=264 K/kW, $R_{th(j-c)D}$=628 K/kW



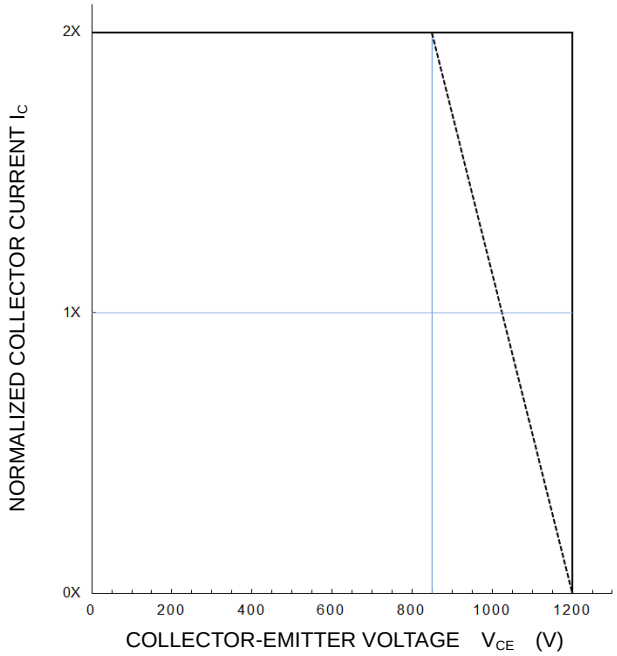
i	1	2	3	4
Ri [K/kW]	0.0124	0.0739	0.3505	0.5632
τi [s]	1.961E-05	0.0014	0.0179	0.0944

PERFORMANCE CURVES

BRAKE PART

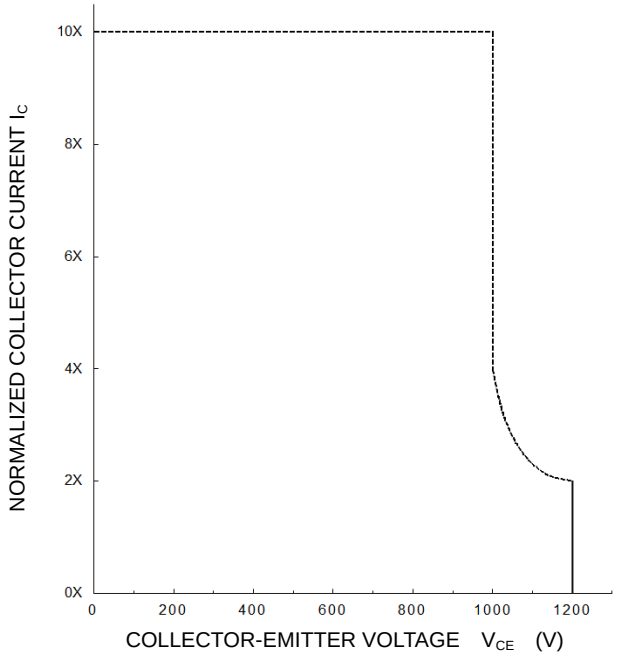
TURN-OFF SWITCHING SAFE OPERATIONG AREA (REVERSE BIAS SAFE OPERATING AREA) (MAXIMUM)

V_{CC}≤850 V, R_G=3.9~40 Ω, V_{GE}=±15 V,
————: T_{vj}=25~150 °C (Normal load operations (Continuous)
- - - - - -: T_{vj}=175 °C (Unusual load operations (Limited period)



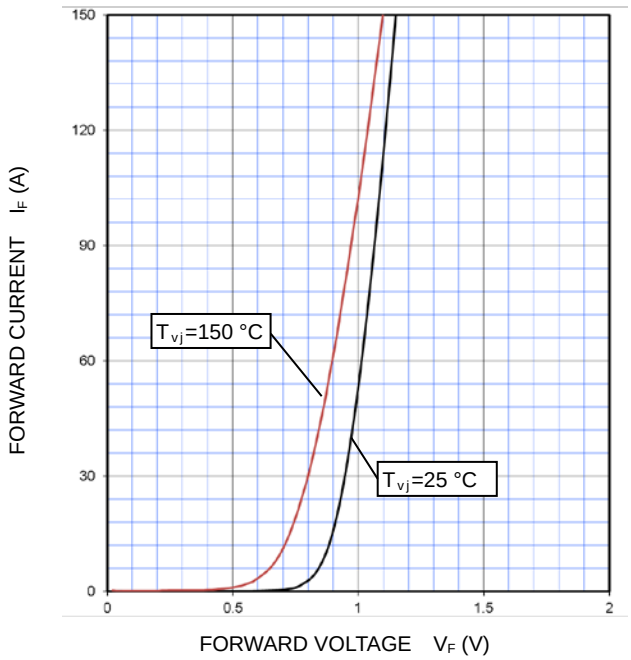
SHORT-CIRCUIT SAFE OPERATING AREA (MAXIMUM)

V_{CC}≤800 V, R_G=3.9~40 Ω, V_{GE}=±15 V,
T_{vj}= 25 ~ 150 °C, t_W≤8 μs, Non-Repetitive



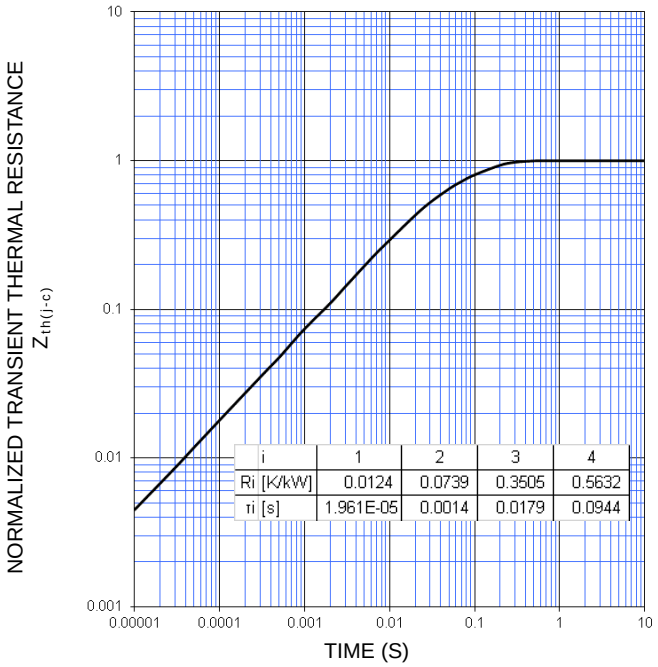
CONVERTER PART

CONVERTER DIODE FORWARD CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS (MAXIMUM)

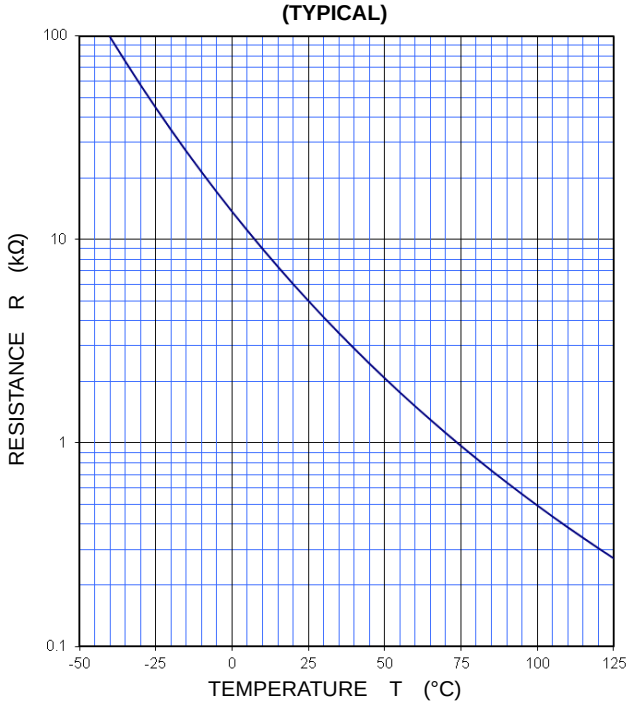
Single pulse, T_C=25 °C
$R_{th(j-c)D}$=324 K/kW



PERFORMANCE CURVES

NTC thermistor part

TEMPERATURE CHARACTERISTICS (TYPICAL)



Note: The characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

Important Notice

The information contained in this datasheet shall in no event be regarded as a guarantee of conditions or characteristics. This product has to be used within its specified maximum ratings, and is subject to customer's compliance with any applicable legal requirement, norms and standards.

Except as otherwise explicitly approved by Mitsubishi Electric Corporation in a written document signed by authorized representatives of Mitsubishi Electric Corporation, our products may not be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

In usage of power semiconductor, there is always the possibility that trouble may occur with them by the reliability lifetime such as Power Cycle, Thermal Cycle or others, or when used under special circumstances (e.g. condensation, high humidity, dusty, salty, highlands, environment with lots of organic matter / corrosive gas / explosive gas, or situations which terminals of semiconductor products receive strong mechanical stress). Therefore, please pay sufficient attention to such circumstances. Further, depending on the technical requirements, our semiconductor products may contain environmental regulation substances, etc. If there is necessity of detailed confirmation, please contact our nearest sales branch or distributor.

The contents or data contained in this datasheet are exclusively intended for technically trained staff. Customer's technical departments should take responsibility to evaluate the suitability of Mitsubishi Electric Corporation product for the intended application and the completeness of the product data with respect to such application. In the customer's research and development, please evaluate it not only with a single semiconductor product but also in the entire system, and judge whether it's applicable. As required, pay close attention to the safety design by installing appropriate fuse or circuit breaker between a power supply and semiconductor products to prevent secondary damage. Please also pay attention to the application note and the related technical information.

Keep safety first in your circuit designs!

Mitsubishi Electric Corporation puts the maximum effort into making semiconductor products better and more reliable, but there is always the possibility that trouble may occur with them. Trouble with semiconductors may lead to personal injury, fire or property damage. Remember to give due consideration to safety when making your circuit designs, with appropriate measures such as (i) placement of substitutive, auxiliary circuits, (ii) use of non-flammable material or (iii) prevention against any malfunction or mishap.

Notes regarding these materials

- These materials are intended as a reference to assist our customers in the selection of the Mitsubishi Electric Semiconductor product best suited to the customer's application; they do not convey any license under any intellectual property rights, or any other rights, belonging to Mitsubishi Electric Corporation or a third party.
- Mitsubishi Electric Corporation assumes no responsibility for any damage, or infringement of any third-party's rights, originating in the use of any product data, diagrams, charts, programs, algorithms, or circuit application examples contained in these materials.
- All information contained in these materials, including product data, diagrams, charts, programs and algorithms represents information on products at the time of publication of these materials, and are subject to change by Mitsubishi Electric Corporation without notice due to product improvements or other reasons. It is therefore recommended that customers contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for the latest product information before purchasing a product listed herein.
  The information described here may contain technical inaccuracies or typographical errors. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability, or other loss rising from these inaccuracies or errors.
  Please also pay attention to information published by Mitsubishi Electric Corporation by various means, including the Mitsubishi Electric Semiconductor home page (https://www.MitsubishiElectric.com/semiconductors/).
- When using any or all of the information contained in these materials, including product data, diagrams, charts, programs, and algorithms, please be sure to evaluate all information as a total system before making a final decision on the applicability of the information and products. Mitsubishi Electric Corporation assumes no responsibility for any damage, liability or other loss resulting from the information contained herein.
- Mitsubishi Electric Corporation semiconductors are not designed or manufactured for use in a device or system that is used under circumstances in which human life is potentially at stake. Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor when considering the use of a product contained herein for any specific purposes, such as apparatus or systems for transportation, vehicular, medical, aerospace, nuclear, or undersea repeater use.
- The prior written approval of Mitsubishi Electric Corporation is necessary to reprint or reproduce in whole or in part these materials.
- If these products or technologies are subject to the Japanese export control restrictions, they must be exported under a license from the Japanese government and cannot be imported into a country other than the approved destination.
  Any diversion or re-export contrary to the export control laws and regulations of Japan and/or the country of destination is prohibited.
- Please contact Mitsubishi Electric Corporation or an authorized Mitsubishi Electric Semiconductor product distributor for further details on these materials or the products contained therein.

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

Mitsubishi Electric:
CM150MXUD-24T